# Supplementary Material: Synchrotron Radiation Photoemission Spectroscopy of Oxygen Modified CrCl<sub>3</sub> Surface

S. Kazim<sup>a</sup>, D. Mastrippolito<sup>b</sup>, P. Moras<sup>c</sup>, M. Jugovac<sup>c</sup>, T. Klimczuk<sup>d</sup>, M. Ali<sup>b,e</sup>, L. Ottaviano<sup>b,f</sup>, R. Gunnella<sup>a,g,h</sup>

<sup>a</sup>Physics Section, School of Science and Technology, University of Camerino, 62032 Camerino (MC), Italy

<sup>b</sup>Dipartimento di Scienze Fisiche e Chimiche (DSFC), Università degli Studi dell'Aquila

<sup>c</sup> Istituto di Struttura della Materia-CNR (ISM-CNR), SS 14, Km 163,5, 34149 Trieste, Italy.

<sup>d</sup> Faculty of Applied Physics and Mathematics, and Advanced Materials Centre, Gdansk University of Technology, ul. Narutowicza 11/12, 80-233 Gdansk, Poland

<sup>e</sup>Department of Physics, Division of Science and Technology, University of Education Lahore, Jauharabad Campus, Pakistan.

<sup>f</sup>CNR-SPIN UoS L'Aquila. Via Vetoio 10 67100 L'Aquila, Italy

<sup>g</sup>INFN-Sez. Perugia, Via Pascoli Perugia, Italy

<sup>h</sup>Corresponding author: Roberto Gunnella, roberto.gunnella@unicam.it

# 1 1. Material preparation:

Starting material details are provided in ref.[1]. Anhydrous chromium(III) chloride (Thermo Scientific) with a 2 purity of 99% was used as a starting material. The powder was stored in an Ar-filled glovebox and XRD characteriza-3 tion is presented in ref.[2]. High-quality single crystals were grown by the self-transport technique, using commercial CrCl<sub>3</sub> powder, that was subjected to an oxygen purification process and then enclosed in a 20 cm quartz tube. The tube was placed in a three-zone furnace with a temperature gradient of about 25°C between the hot and cold zones. The hot end of the furnace was heated to 1000°C, held for an hour at a constant temperature, and then gradually cooled to 700°C at a cooling rate of 3°C/hour. Then the quartz tube was kept at 700°C temperature for 7 days. The rown crystals were stored in a glove box filled with argon gas. The samples were eventually cleaved both in vacuum 9 as well as in air for better experimental comparison [3, 4]. Magnetic characterization is provided in ref.[3], Serri et 10 al. demonstrated the larger antiferromagnetic interaction or anisotropy on exfoliated CrCl<sub>3</sub> ( $\approx$  10 nm thick) by X-ray 11 magnetic circular dichroism (XMCD) and Magnetic force microscopy (MFM) than in bulk. 12

### <sup>13</sup> 2. Cl 2p core level spectra taken at 300°C :

The Cl 2p spectra at 300°C consist of more components than at 150°C. As we mentioned in the main text, such extra components are related to the increasing number of vacancies per unit surface.



Figure SM1: Cl 2p core level spectra including data at 300 °C with different incident photon energies:(a) UHV cleaved spectra. (b) Air cleaved spectra.

# 16 3. Cr3p Spectra



Figure SM2: Cr 3p core level spectra including satellite features at 150 °C with different incident photon energies.

#### 17 4. Valence Band



Figure SM3: VB spectra including satellite features at 150 °C.

Additional information on the correlation of the electronic structure can be obtained from the satellites energy as shown in Fig SM 2 and Fig SM3 respectively. The satellite features are mainly related to the metal-ligand hybridization and electron-electron interactions confirming the nature of CrCl<sub>3</sub> MH compound, while a trend towards charge transfer is observed on the surface sensitive spectra when the satellite is missing.

## 22 5. CTM4XAS (charge transfer multiplets for XAS/XPS) :

The CTM4XAS program is used to analyze the charge transfer effect for 2p and 3p core level spectra of transition metals recorded by X-ray absorption (XAS), X-ray photoemission (XPS), or electron energy loss spectroscopy (EELS). More details on the software can be found in ref [5]. We applied the theoretical model on Cr 2p and Cr 3p in the most probable valence state i.e. (Cr<sup>+3</sup>). This calculation consists of set of appropriate parameters for charge transfer, such as the crystal field (10Dq), the charge transfer energy ( $\Delta$ ), the average Coulomb interaction (U<sup>dd</sup> - U<sup>pd</sup>),

<sup>28</sup> and the energy splitting (e<sup>g</sup> and T<sup>2g</sup>). For Cr 2p,the Slater integral and spin- orbit coupling (SO) reduction were used

<sup>29</sup> as default (i.e., 100%), but for the Cr 3p core-level spectra, the value of the SO coupling reduction was kept at zero.

<sup>30</sup> Our spectra here consist of two principal components, one related to the multiplet effect (majority) and the other to

<sup>31</sup> charge transfer (minority). Consequently, two calculations were performed and compared to the experimental spectra.

<sup>32</sup> The linear combination of the two contributions as a whole is then shift rigidly to fit the experimental energy.

#### **6.** Corrected XPS atomic sensitivity for photon energy:

To determine the surface composition of the exfoliated  $CrCl_3$  flakes, the atomic sensitivity factor correction was calculated using the following formula, taking into account the variable kinetic energy of the photoemitted electrons:

$$\frac{S_{Cr}}{S_{Cl}} = \left(\frac{\sigma_{Cr}}{\sigma_{Cl}}\right) * \left(\frac{K.E.c_r}{K.E.c_l}\right)^{0.66} [6]$$
(SM1)

For better understanding, we have presented a numerical example of the sensitivity correction at 700 eV photon energy:

$$\left(\frac{K.E._{Cr}}{K.E._{Cl}}\right)^{0.66} = \left(\frac{130}{500}\right)^{0.66} = 0.44 \tag{SM2}$$

<sup>38</sup> So, the corrected sensitivity ratio is :

$$\frac{S_{Cr}}{S_{Cl}} = 0.44 * 3.1 = 1.38 \approx 1.4$$
(SM3)

<sup>39</sup> All atomic sensitivity ratios have been calculated in a similar way for other elements.

#### 40 References

- [1] D. Mastrippolito, L. Ottaviano, J. Wang, J. Yang, F. Gao, M. Ali, G. D'Olimpio, A. Politano, S. Palleschi, S. Kazim, et al., Emerging oxidized
- 42 and defective phases in low-dimensional CrCl<sub>3</sub>, Nanoscale Advances 3 (2021) 4756–4766. doi:10.1039/D1NA00401H.

[2] S. Kazim, R. Gunnella, M. Zannotti, R. Giovannetti, T. Klimczuk, L. Ottaviano, Determination of the refractive index and wavelength dependent optical properties of few-layer CrCl<sub>3</sub> within the Fresnel formalism, J. of Microscopy 283 (2021) 145. doi:10.1111/jmi.13015.

45 [3] M. Serri, G. Cucinotta, L. Poggini, G. Serrano, P. Sainctavit, J. Strychalska-Nowak, A. Politano, F. Bonaccorso, A. Caneschi, J. Cava,

46 R. Sessoli, L. Ottaviano, T. Klimczuk, V. Pellegrini, M. Mannini, Enhancement of the Magnetic Coupling in Exfoliated CrCl<sub>3</sub> Crys-

tals Observed by Low-Temperature Magnetic Force Microscopy and X-ray Magnetic Circular Dichroism, Adv. Mat 32 (2020) 2000566.
doi:10.1002/adma.202000566.

[4] S. Kazim, M. Ali, S. Palleschi, G. D'Olimpio, D. Mastrippolito, A. Politano, R. Gunnella, A. Di Cicco, M. Renzelli, G. Moccia, et al., Me-

chanical exfoliation and layer number identification of single crystal monoclinic CrCl<sub>3</sub>, Nanotechnology (2020). doi:10.1088/1361-6528/
ab7de6.

- 52 [5] E. Stavitski, F. M. De Groot, The CTM4XAS program for EELS and XAS spectral shape analysis of transition metal L edges, Micron 41
- 53 (2010) 687-694. doi:10.1016/j.micron.2010.06.005.
- 54 [6] J. Yeh, I. Lindau, Atomic subshell photoionization cross sections and asymmetry parameters: 1 Z 103, Atomic data and nuclear data tables 32
- <sup>55</sup> (1985) 1–155. doi:10.1016/0092-640X(85)90016-6.